

Search Notes

Application/Control No.

10/669,926

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

3739

SEARCHED

Class	Subclass	Date	Examiner
606	169	9/12/2006	VWC
604	21,22	9/12/2006	VWC
606	1	9/12/2006	VWC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search from Mike Peffley (see under SEARCHED)	9/12/2006	VWC
EAST search (see attached)	9/12/2006	VWC